May 4, 2005

Special Test Request Form

STR Number 9

Part 1 – Test Definition Section

Test Requestor: Gary Godfrey and Tune Kamae

Test Purpose and Justification:

The LAT needs a bias-free trigger and latch efficiency measurement. We propose to add two small scintillators to the existing LAT Muon Telescope and record times (GPS) of the muon crossings during selected 2-Tower tests. The Muon Telescope data will be recorded independently of the Tower A&B readout. We will correlate the recorded Muon Telescope times with the trigger times recorded in the LAT events by the standard data acquisition. Muon crossings that did not trigger the 2-Towers will be interpreted as an overall inefficiency. We will compare the measured overall inefficiency with that predicted by Monte Carlo.

Test Description:

The test operates parasitically during 2-Tower testing. The test will record Muon Telescope times on the BGO DAQ, totally independent of the 2-Tower test DAQ, while E2E and SVAC runs are occurring. After the test, muon telescope data will be compared with the pipe-line output from the 2-Tower test.

GSE Configuration:

- 1) The existing E2E and SVAC test configuration for the Two Towers.
- 2) Two small scintillators (7.5" x 15") added to the existing LAT Muon Telescope (making a coincidence of 4 scintillators). Note that the standard E2E and SVAC tests will still only see a two fold coincidence of the large scintillators as originally planned. The 4 fold is used only in the separated data stream used for this test.
- 3) The BGO DAQ configured to record GPS times from the muon telescope events (rather than the BGO). The Muon Telescope will only trigger the BGO DAQ, **not** the Two Towers.

LAT Configuration:

- 1) The existing E2E and SVAC tests' upright orientation for the Two Towers.
- 2) The 4 scintillator Muon Telescope will be placed around the LAT so that every ray that goes through the small scintillators must go through the two towers.

Expected Results/Acceptance Criteria:

Expected results: TKR trigger and latching efficiencies and any position dependence over the areas illuminated.

Acceptance Criteria: None. The results will be written as a report and fed back to the collaboration.

Expected Duration:

Entire 2-Tower test interval with no additional time needed. The BGO DAQ will run simultaneously with E2E and SVAC tests that are already in the schedule.

Expected Analysis Duration:

4 weeks after test completion.

Test Procedure:

- 1) Set up the 4 scintillator muon telescope so that all rays through the two small scintillators pass through the two towers.
- 2) Start/stop the MUON acquisition program (on the BGO DAQ computer) within a few minutes of the Start/Stop of the E2E and SVAC test runs.

Test Script:

No new scripts.

Part 2 – Impact Assessment Section

Procedure development:

A minimal change is needed to all procedures for which the new data taking is operative. The procedure change required is to perform the same action as simultaneously Starting/Stopping BGO runs when Tower A was taking Van de Graaff data, except that MUON rather than BGO is typed.

Script development and checkout:

None. The E2E and SVAC test scripts are the existing ones. The program MUON for the BGO DAQ is already written and tested.

Impact to schedule:

None. No additional time is needed.

Risk Assessment:

None. The successful completion E2E and SVAC tests are **not** contingent on the Muon runs being successfully recorded by the BGO DAQ.

Required Resources:

The BGO DAQ (done), the LAT Muon Telescope, two additional small scintillators (already installed), ~5 days of Gary Godfrey's time setting up the apparatus and writing docs, ~5 days of Tune Kamae's time, ~2 weeks of Tune Kamae's post-doc's time analyzing the data, and ~1/4 day I&T electrical engineer's time to modify the AIDS for E2E and SVAC data taking. The AIDs will call out LAT-PS-06614 (Procedure for Taking Simultaneous Muon Telescope and LAT Data) when all E2E and SVAC runs are executed for the 2-Tower test.

Other Affected Parties:

Reviewers.

| Part 3: Signature Approval: | | | |
|--------------------------------|---|-----------|------|
| Required Authorizations | Printed Name | Signature | Date |
| Quality | Joe Cullinan | | |
| I&T | Elliott Bloom | | |
| Program Office | Lowell Klaisner or Dick Horn | | |
| Systems Engineering | Pat Hascall | | |
| Affected S/S managers | N/A | | |
| Instrument Scientist | Steve Ritz or Eduardo do Couto e Silva | | |
| | N/A | | |
| Other | N/A | | |
| Other | N/A | | |
| Other | N/A | | |